

N-Channel Enhancement Mode MOSFET

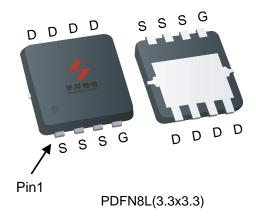
Feature

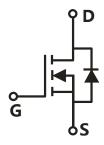
- 60V/55A $R_{DS(ON)} = 8.2 \text{ m}\Omega(\text{typ.}) \text{ @VGS} = 10V$
- 100% Avalanche Tested
- 100% DVDS
- Reliable and Rugged
- Halogen Free and Green Devices Available (RoHS Compliant)

Applications

- Switching application
- Li-battery protection
- Power Management for DC/DC

Pin Description





Single N-Channel MOSFET

Ordering and Marking Information



Package Code

C1: PDFN8L(3.3x3.3)

Date Code XYMXXXXXX

Note: HUAYI halogen free products contain molding compounds/die attach materials and 100% matte tin plate Termi-Nation finish; which are fully compliant with RoHS. HUAYI halogen free products meet or exceed the halogen free require-ments of IPC/JEDEC J-STD-020 for MSL classification at halogen free peak reflow temperature. HUAYI defines "Green" to mean halogen free (RoHS compliant) and halogen free (Br or CI does not exceed 900ppm by weight in homogeneous material and total of Br and CI does not exceed 1500ppm by weight).

HUAYI reserves the right to make changes, corrections, enhancements, modifications, and improvements to this pr-oduct and/or to this document at any time without notice.



Absolute Maximum Ratings

Symbol	Parameter	Rating	Unit			
Common Rat	Common Ratings (Tc=25°C Unless Otherwise Noted)					
VDSS	Drain-Source Voltage		60	V		
Vgss	Gate-Source Voltage		±20	V		
TJ	Junction Temperature Range		55 1. 475	°C		
Тѕтс	Storage Temperature Range		-55 to 175	°C		
Is	Source Current-Continuous(Body Diode) Tc=25°C		55	А		
Mounted on I	Mounted on Large Heat Sink					
Ідм	Pulsed Drain Current *	Tc=25°C	160	А		
	ID Continuous Drain Current		55	А		
ID			38.9	А		
1	Martin or Broad Pirate of the	Tc=25°C	58.8	W		
PD	P _D Maximum Power Dissipation Tc=100°C		29.4	W		
R₀JC	Thermal Resistance, Junction-to-Case		2.55	°C/W		
R _{eJA}	Thermal Resistance, Junction-to-Ambient **		100	°C/W		
Eas	Single Pulsed-Avalanche Energy *** L=0.3mH		84	mJ		

Note:

- * Repetitive rating; pulse width limited by max.junction temperature.
- ** Surface mounted on 1in2 FR-4 board.
- *** Limited by TJmax , starting TJ=25°C, L = 0.3mH, Rg= 25Ω , Vgs =10V.

Electrical Characteristics(Tc =25°C Unless Otherwise Noted)

Cumhal	Davamatar	Test Conditions	HY	HYG092N06LS1		
Symbol	Parameter	lest Conditions	Min	Тур.	Max	Unit
Static Cha	racteristics					
BVDSS	Drain-Source Breakdown Voltage	V _{GS} =0V,I _{DS} =250μA	60	-	-	V
Building and Lader Count		VDS=60V,VGS=0V	-	-	1	μΑ
IDSS	Drain-to-Source Leakage Current	TJ=125°C	-	-	50	μΑ
VGS(th)	Gate Threshold Voltage	V _{DS} =V _{GS} , I _{DS} =250µA	1.3	2.1	2.5	V
lgss	Gate-Source Leakage Current	Vgs=±20V,Vps=0V	-	-	±100	nA
Dagger	Drain Source On State Registeres	V _{GS} =10V,I _{DS} =20A	-	8.2	9.8	mΩ
RDS(ON) Drain-Source On-State Resistance		V _{GS} =6V,I _{DS} =10A	-	10.5	15	
Diode Cha	Diode Characteristics					
VsD	Diode Forward Voltage	IsD=20A,Vgs=0V	-	0.88	1.2	V
trr	Reverse Recovery Time	lan 2014 dlan/dt 1001/up	-	23	-	ns
Qrr	Reverse Recovery Charge	- Isb=20A,dIsb/dt=100A/μs	-	21	-	nC



Electrical Characteristics (Cont.) (Tc =25°C Unless Otherwise Noted)

Comple al	Parameter	Tank Camalikiana	HY	HYG092N06LS1		
Symbol		Test Conditions	Min	Тур.	Max	Unit
Dynamic (Characteristics					
Rg	Gate Resistance	V _{GS} =0V,V _{DS} =0V,F=1MHz	-	0.9	-	Ω
Ciss	Input Capacitance	Vgs=0V,	-	1020	-	
Coss	Output Capacitance	V _{DS} =25V,	-	330	-	pF
Crss	Reverse Transfer Capacitance	Frequency=1MHz	-	24	-	
td(ON)	Turn-on Delay Time		-	8.7	-	
Tr	Turn-on Rise Time	$V_{DD}=30V,R_{G}=4\Omega,$	-	32	-	
td(OFF)	Turn-off Delay Time	IDS=20A,VGS=10V	-	17	-	ns
Tf	Turn-off Fall Time		-	23	-	
Gate Char	Gate Charge Characteristics					
Qg	Total Gate Charge(V _{GS} =10V)		-	18	-	
Qgs	Gate-Source Charge	\/ _40\/ _20\	-	4.8	-	nC
Qgd	Gate-Drain Charge	V_{DS} =48V, I_{DS} =20A	-	3.8	-	
V _{plateau}	Gate plateau voltage		-	4.2	-	V

Note: *Pulse test, pulse width ≤ 300 us, duty cycle $\leq 2\%$



Typical Operating Characteristics

Figure 1: Power Dissipation

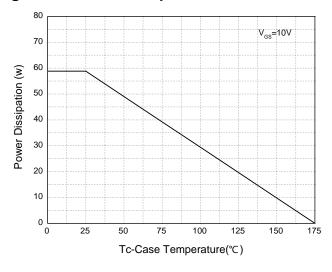


Figure 2: Drain Current

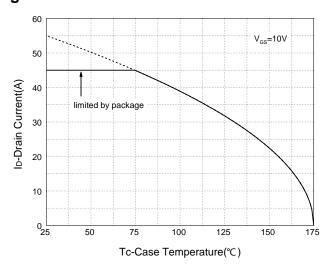


Figure 3: Safe Operation Area

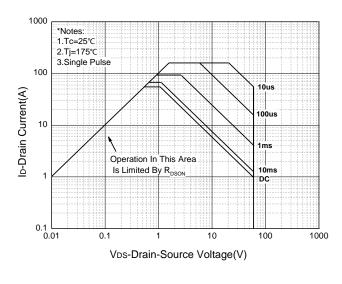


Figure 4: Thermal Transient Impedance

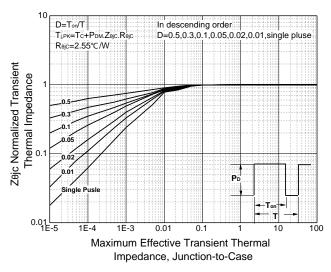


Figure 5: Output Characteristics

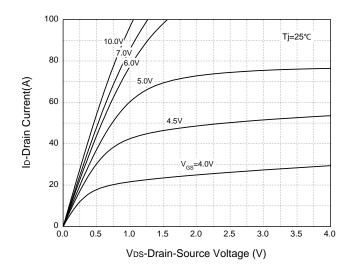
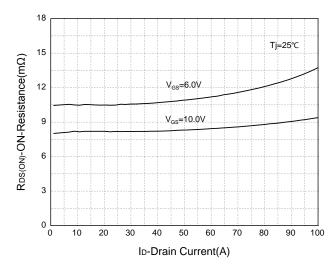


Figure 6: Drain-Source On Resistance





Typical Operating Characteristics(Cont.)

Figure 7: On-Resistance vs. Temperature

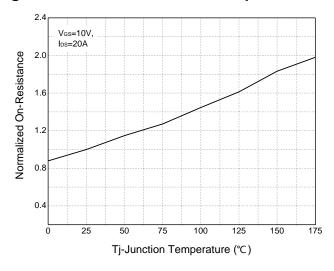


Figure 8: Source-Drain Diode Forward

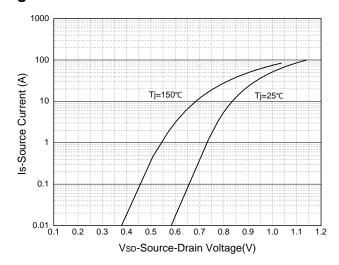


Figure 9: Capacitance Characteristics

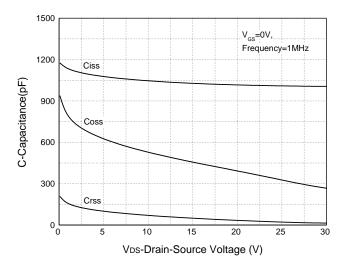
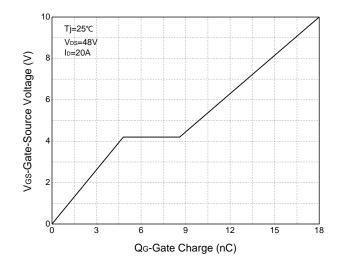
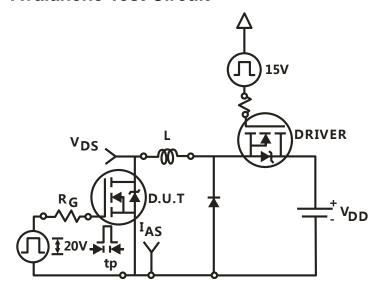


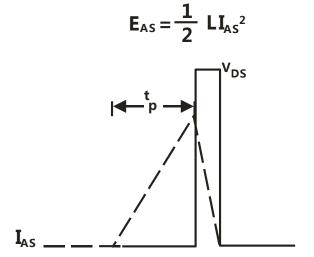
Figure 10: Gate Charge Characteristics



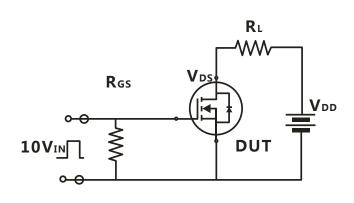


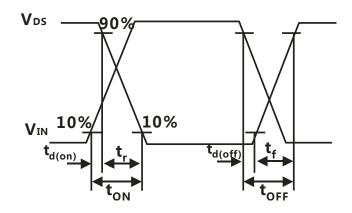
Avalanche Test Circuit



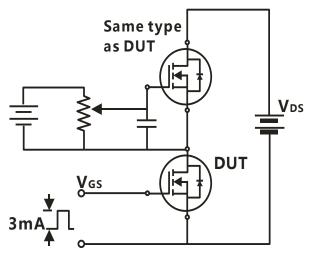


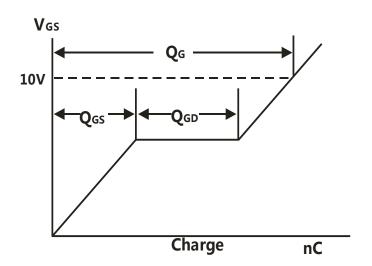
Switching Time Test Circuit





Gate Charge Test Circuit





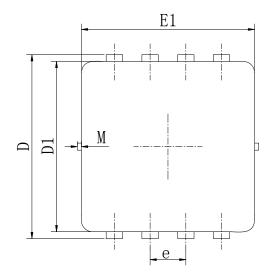


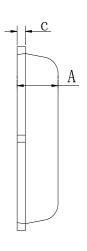
Device Per Unit

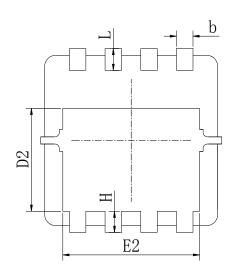
Package Type	Unit	Quantity
PDFN8L(3.3x3.3)	Reel	6500

Package Information

PDFN8L(3.3x3.3)



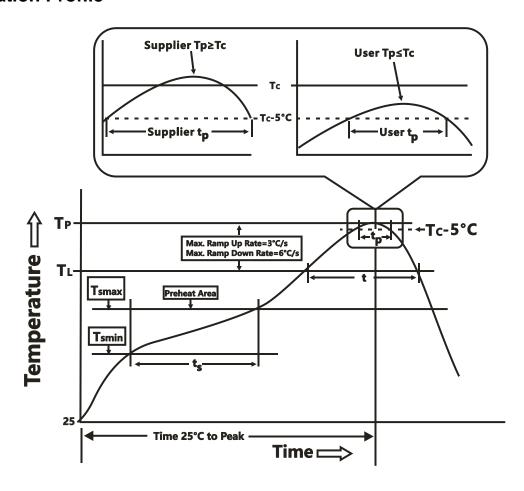




COMMON DIMENSIONS				
SYMBOL	mm			
STIVIBOL	MIN	NOM	MAX	
Α	0.70	0.75	0.80	
b	0.25	0.30	0.35	
С	0.10	0.15	0.25	
D	3.25	3.35	3.45	
D1	3.00	3.10	3.20	
D2	1.78	1.88	1.98	
E1	3.10	3.20	3.30	
E2	2.44	2.54	2.64	
е	0.65BSC			
Н	0.30	0.39	0.50	
L	0.30	0.40	0.50	
M	\	\	0.10	
*Not specified				



Classification Profile



Classification Reflow Profiles

Profile Feature	Sn-Pb Eutectic Assembly	Pb-Free Assembly		
Preheat & Soak				
Temperature min (T _{smin})	100 °C	150 °C		
Temperature max (T _{smax})	150 °C	200 °C		
Time (Tsmin to Tsmax) (t _s)	60-120 seconds	60-120 seconds		
Average ramp-up rate	2.00/2.2.2.1.d may	200/20024 7504		
(T _{smax} to T _P)	3 °C/second max.	3°C/second max.		
Liquidous temperature (T _L)	183 °C	217 °C		
Time at liquidous (t∟)	60-150 seconds	60-150 seconds		
Peak package body Temperature (Tp)*	See Classification Temp in table 1	SeeClassification Tempin table 2		
Time (t _P)** within 5°C of the specified	20** seconds	30** seconds		
classification temperature (T _c)	20 Seconds	30 Seconds		
Average ramp-down rate (Tpto Tsmax)	6 °C/second max.	6 °C/second max.		
Time 25°C to peak temperature	6 minutes max.	8 minutes max.		
*Tolorope for peak profile Temperature (T.) is defined as a cumplior minimum and a user maximum				

^{*}Tolerance for peak profile Temperature (T_P) is defined as a supplier minimum and a user maximum.

^{**} Tolerance for time at peak profile temperature (tp) is defined as a supplier minimum and a user maximum.

HYG092N06LS1C1



Table 1.SnPb Eutectic Process – Classification Temperatures (Tc)

Package Thickness	Volume mm³ <350	Volume mm³ ≥350
<2.5 mm	235 °C	220 °C
≥2.5 mm	220 °C	220 °C

Table 2.Pb-free Process – Classification Temperatures (Tc)

Package	Volume mm³	Volume mm³	Volume mm³
Thickness	<350	350-2000	≥2000
<1.6 mm	260 °C	260 °C	260 °C
1.6 mm – 2.5 mm	260 °C	250 °C	245 °C
≥2.5 mm	250 °C	245 °C	245 °C

Reliability Test Program

Test item	Method	Description
SOLDERABILITY	JESD-22, B102	5 Sec, 245°C
HTRB	JESD-22, A108	168/500 Hrs, Bias @ 150°C
HTGB	JESD-22, A108	168 /500 Hrs, V _{gs} 100% @ 150°C
PCT	JESD-22, A102	96 Hrs, 100%RH, 2atm, 121°C
TCT	JESD-22, A104	250/500 Cycles, -55°C~150°C

Customer Service

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